

SANYO Semiconductors DATA SHEET

TND308TD

ExPD (Excellent Power Device)

General Purpose Driver for PDP Sustain Pulse Drive, Motor Drive, Switching Power Supply, and DC / DC Converter Applications

Features

- · Dual buffer.
- · Monolithic structure(High voltage CMOS process adopted).
- · Withstand voltage of 25V is assured.
- Wide range of operating voltage: 4.5V to 25V.
- · Peak output current: 1A.
- Fast switching time(30ns typical at 1000pF load).
- Fully compatible input to TTL/CMOS (V_{IH}=not more than 2.6V, at V_{DD}=4.5 to 25V).

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Supply Voltage	VDD		0 to 25	V
Input Voltage	VIN		GND-0.3 to V _{DD} +0.3	V
Allowable Power Dissipation	P _D max		0.25	W
Junction Temperature	Tj		-55 to +150	°C
Storage Temperature	Tstg		-55 to +150	°C

Recommended Operating Conditions at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Operating Supply Voltage	V _{DD}		4.5 to 25	V
Operating Temperature	Topr		-40 to +125	°C

Electrical Characteristics (AC Characteristics) at Ta=25°C, VDD=18V, VIN=5V

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Turn-On Rise Time	t _r	C _L =1000pF		30	45	ns
Turn-Off Fall Time	tf	CL=1000pF		30	45	ns
Delay Time	t _D 1	C _L =1000pF		30	45	ns
	tD2	CL=1000pF		45	60	ns

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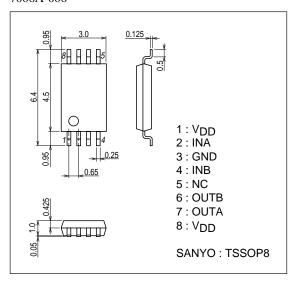
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Electrical Characteristics (DC Characteristics) at Ta=25 $^{\circ}$ C, VDD=4.5 to 25V

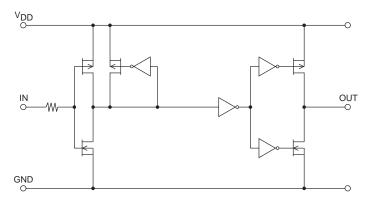
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Onit
Logic "1" Input Voltage	VIH		2.6			V
Logic "0" Input Voltage	VIL				0.8	V
Input Bias Current	liN	VIN=0 or VDD	-1		1	μΑ
High Level Output Voltage	Voн	IO=0	V _{DD} -0.1			V
Low Level Output Voltage	VOL	I _O =0			0.1	V
V _{DD} Supply Current	Isupp	V _{DD} =10V, V _{IN} =3V, (both inputs)		1.0	4.5	mA
		V _{DD} =10V, V _{IN} =0, (both inputs)			0.2	mA
Output High Short Circuit Pulse Current	IO+	V _{DD} =18V, PW≤10μs, V _{OUT} =0		1.0		Α
Output Low Short Circuit Pulse Current	10-	V _{DD} =18V, PW≤10μs, V _{OUT} =18V		1.0		Α
Output On Resistance	ROUT	V _{DD} =18V, Iload=10mA, V _{OUT} ="H"		8	12	Ω
		VDD=18V, Iload=10mA, VOUT="L"		6	10	Ω

Package Dimensions

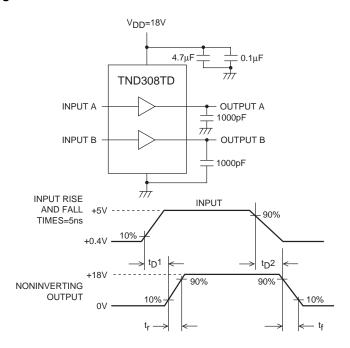
unit : mm 7006A-006

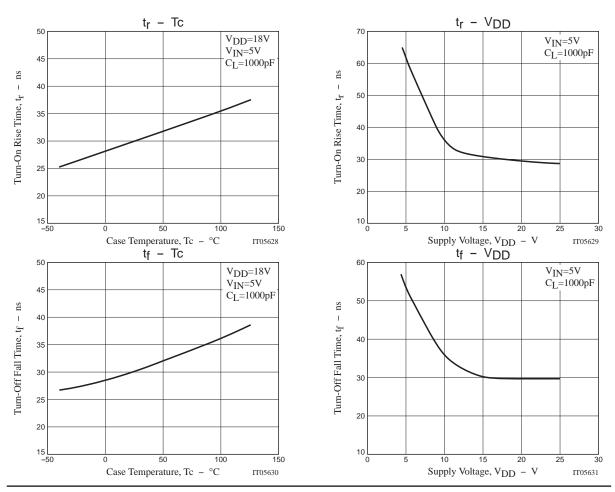


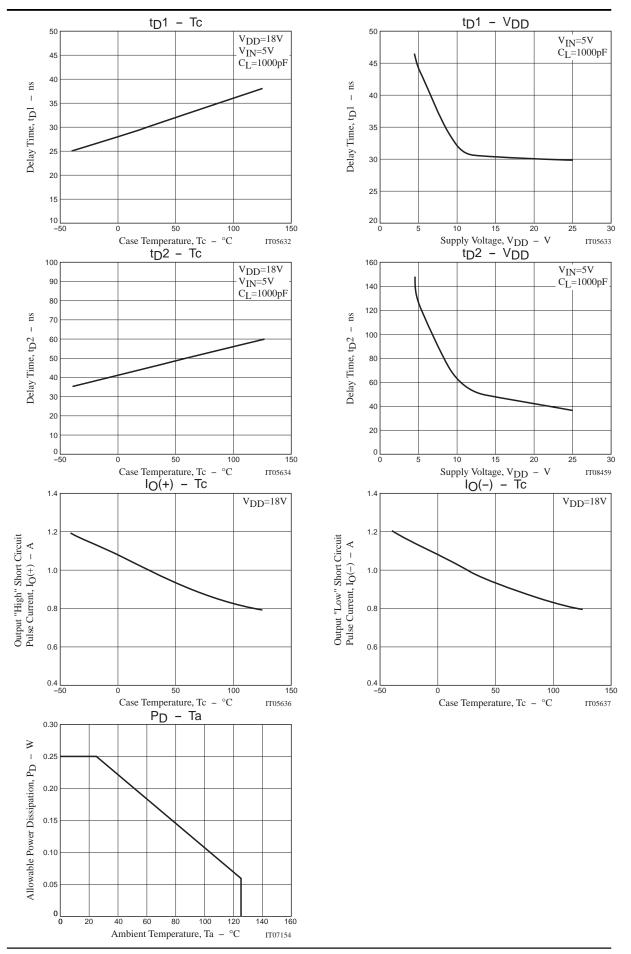
Block Diagram



Switching Time Test Circuit







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